

Features

- 32768x8 bit static CMOS RAM
- Access times 70 ns, 100 ns
- Common data inputs and data outputs
- Three-state outputs
- Typ. operating supply current
 - 70 ns: 50 mA
 - 100 ns: 40 mA
- TTL/CMOS-compatible
- Automatical reduction of power dissipation in long Read Cycles
- Power supply voltage $5\text{ V} \pm 10\%$
- Operating temperature ranges
 - 0 to 70 °C
 - 40 to 85 °C
 - 40 to 125 °C
- QS 9000 Quality Standard
- ESD protection > 2000 V (MIL STD 883C M3015.7)
- Latch-up immunity >100 mA
- Packages: PDIP28 (600 mil)
SOP28 (330 mil)

Description

The U62256A is a static RAM manufactured using a CMOS process technology with the following operating modes:

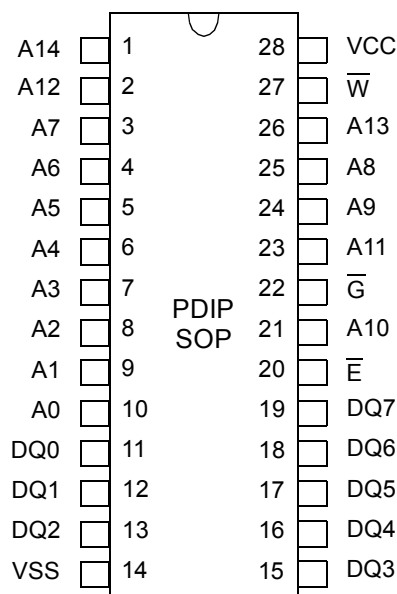
- Read
- Standby
- Write
- Data Retention

The memory array is based on a 6-transistor cell.

The circuit is activated by the falling edge of \overline{E} . The address and control inputs open simultaneously. According to the information of \overline{W} and \overline{G} , the data inputs, or outputs, are active. In a Read cycle, the data outputs are activated by the falling edge of \overline{G} , afterwards the data word read will be available at the outputs DQ0-DQ7. After the address change, the data outputs go High-Z until the new information read is available. The data outputs have not preferred state. The Read cycle is finished by the

falling edge of \overline{W} , or by the rising edge of \overline{E} , respectively. Data retention is guaranteed down to 2 V. With the exception of \overline{E} , all inputs consist of NOR gates, so that no pull-up/pull-down resistors are required.

Pin Configuration



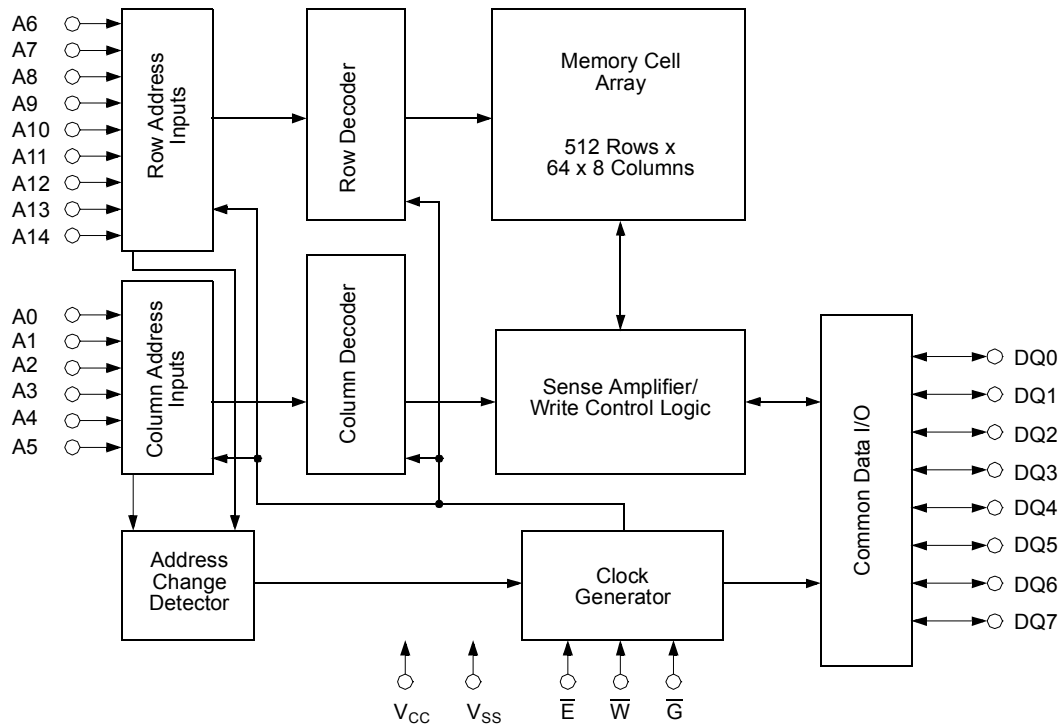
Top View

Pin Description

Signal Name	Signal Description
A0 - A14	Address Inputs
DQ0 - DQ7	Data In/Out
\overline{E}	Chip Enable
\overline{G}	Output Enable
\overline{W}	Write Enable
VCC	Power Supply Voltage
VSS	Ground

U62256A

Block Diagram



Truth Table

Operating Mode	\bar{E}	\bar{W}	\bar{G}	DQ0 - DQ7
Standby/not selected	H	*	*	High-Z
Internal Read	L	H	H	High-Z
Read	L	H	L	Data Outputs Low-Z
Write	L	L	*	Data Inputs High-Z

* H or L

Characteristics

All voltages are referenced to $V_{SS} = 0$ V (ground).

All characteristics are valid in the power supply voltage range and in the operating temperature range specified.

Dynamic measurements are based on a rise and fall time of ≤ 5 ns, measured between 10 % and 90 % of V_i , as well as input levels of $V_{IL} = 0$ V and $V_{IH} = 3$ V. The timing reference level of all input and output signals is 1.5 V, with the exception of the t_{dis} -times and t_{en} -times, in which cases transition is measured ± 200 mV from steady-state voltage.

Absolute Maximum Ratings ^a		Symbol	Min.	Max.	Unit
Power Supply Voltage		V_{CC}	-0.5	7	V
Input Voltage		V_I	-0.5	$V_{CC} + 0.5$ ^b	V
Output Voltage		V_O	-0.5	$V_{CC} + 0.5$ ^b	V
Power Dissipation		P_D	-	1	W
Operating Temperature	C-Type	T_a	0	70	°C
	K-Type		-40	85	
	A-Type		-40	125	
Storage Temperature	C/K-Type	T_{stg}	-65	125	°C
	A-Type		-65	150	
Output Short-Circuit Current at $V_{CC} = 5$ V and $V_O = 0$ V ^c		$ I_{OS} $		200	mA

^a Stresses greater than those listed under „Absolute Maximum Ratings“ may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at condition above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability

^b Maximum voltage is 7 V

^c Not more than 1 output should be shorted at the same time. Duration of the short circuit should not exceed 30 s.

Recommended Operating Conditions	Symbol	Conditions	Min.	Max.	Unit
Power Supply Voltage	V_{CC}		4.5	5.5	V
Input Low Voltage ^d	V_{IL}		-0.3	0.8	V
Input High Voltage	V_{IH}		2.2	$V_{CC} + 0.3$	V

^d -2 V at Pulse Width 10 ns

U62256A

Electrical Characteristics	Symbol	Conditions	Min.	Max.	Unit
Supply Current - Operating Mode	$I_{CC(OP)}$	$V_{CC} = 5.5\text{ V}$ $V_{IL} = 0.8\text{ V}$ $V_{IH} = 2.2\text{ V}$ $t_{cW} = 70\text{ ns}$ $t_{cW} = 100\text{ ns}$		70 65	mA mA
Supply Current - Standby Mode (CMOS level)	$I_{CC(SB)}$	$V_{CC} = 5.5\text{ V}$ $V_{\bar{E}} = V_{CC} - 0.2\text{ V}$ C-Type K-Type A-Type		5 10 50	μA μA μA
Supply Current - Standby Mode (TTL level)	$I_{CC(SB)1}$	$V_{CC} = 5.5\text{ V}$ $V_{\bar{E}} = 2.2\text{ V}$		1	mA
Output High Voltage	V_{OH}	$V_{CC} = 4.5\text{ V}$ $I_{OH} = -1.0\text{ mA}$	2.4		V
Output Low Voltage	V_{OL}	$V_{CC} = 4.5\text{ V}$ $I_{OL} = 3.2\text{ mA}$		0.4	V
Input High Leakage Current	I_{IH}	$V_{CC} = 5.5\text{ V}$ $V_{IH} = 5.5\text{ V}$		2	μA
Input Low Leakage Current	I_{IL}	$V_{CC} = 5.5\text{ V}$ $V_{IL} = 0\text{ V}$	-2		μA
Output High Current	I_{OH}	$V_{CC} = 4.5\text{ V}$ $V_{OH} = 2.4\text{ V}$		-1	mA
Output Low Current	I_{OL}	$V_{CC} = 4.5\text{ V}$ $V_{OL} = 0.4\text{ V}$	3,2		mA
Output Leakage Current High at Three-State Outputs	I_{OHZ}	$V_{CC} = 5.5\text{ V}$ $V_{OH} = 5.5\text{ V}$		1	μA
Low at Three-State Outputs	I_{OLZ}	$V_{CC} = 5.5\text{ V}$ $V_{OL} = 0\text{ V}$	-1		μA

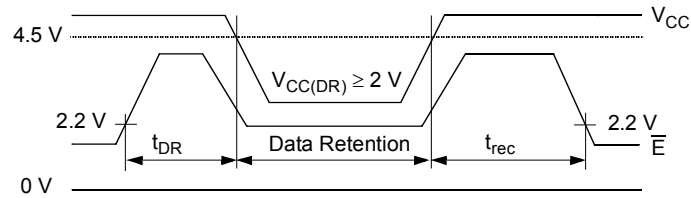
Switching Characteristics Read Cycle	Symbol		07		10		Unit
	Alt.	IEC	Min.	Max.	Min.	Max.	
Read Cycle Time	t_{RC}	t_{cR}	70		100		ns
Address Access Time to Data Valid	t_{AA}	$t_{a(A)}$		70		100	ns
Chip Enable Access Time to Data Valid	t_{ACE}	$t_{a(E)}$		70		100	ns
Output Enable Access Time to Data Valid	t_{OE}	$t_{a(G)}$		35		45	ns
\bar{E} HIGH to Output in High-Z	t_{HZCE}	$t_{dis(E)}$		25		35	ns
\bar{G} HIGH to Output in High-Z	t_{HZOE}	$t_{dis(G)}$		25		35	ns
\bar{E} LOW to Output in Low-Z	t_{LZCE}	$t_{en(E)}$	5		5		ns
\bar{G} LOW to Output in Low-Z	t_{LZOE}	$t_{en(G)}$	0		0		ns
Output Hold Time from Address Change	t_{OH}	$t_{v(A)}$	5		5		ns

Switching Characteristics Write Cycle	Symbol		07		10		Unit
	Alt.	IEC	Min.	Max.	Min.	Max.	
Write Cycle Time	t_{WC}	t_{cW}	70		100		ns
Write Pulse Width	t_{WP}	$t_{w(W)}$	55		70		ns
Write Pulse Width Setup Time	t_{WP}	$t_{su(W)}$	55		70		ns
Address Setup Time	t_{AS}	$t_{su(A)}$	0		0		ns
Address Valid to End of Write	t_{AW}	$t_{su(A-WH)}$	65		80		ns
Chip Enable Setup Time	t_{CW}	$t_{su(E)}$	65		80		ns
Pulse Width Chip Enable to End of Write	t_{CW}	$t_{w(E)}$	65		80		ns
Data Setup Time	t_{DS}	$t_{su(D)}$	30		35		ns
Data Hold Time	t_{DH}	$t_{h(D)}$	0		0		ns
Address Hold from End of Write	t_{AH}	$t_{h(A)}$	0		0		ns
\bar{W} LOW to Output in High-Z	t_{HZWE}	$t_{dis(W)}$		25		35	ns
\bar{G} HIGH to Output in High-Z	t_{HZOE}	$t_{dis(G)}$		25		35	ns
\bar{W} HIGH to Output in Low-Z	t_{LZWE}	$t_{en(W)}$	0		0		ns
\bar{G} LOW to Output in Low-Z	t_{LZOE}	$t_{en(G)}$	0		0		ns

U62256A

Data Retention Mode

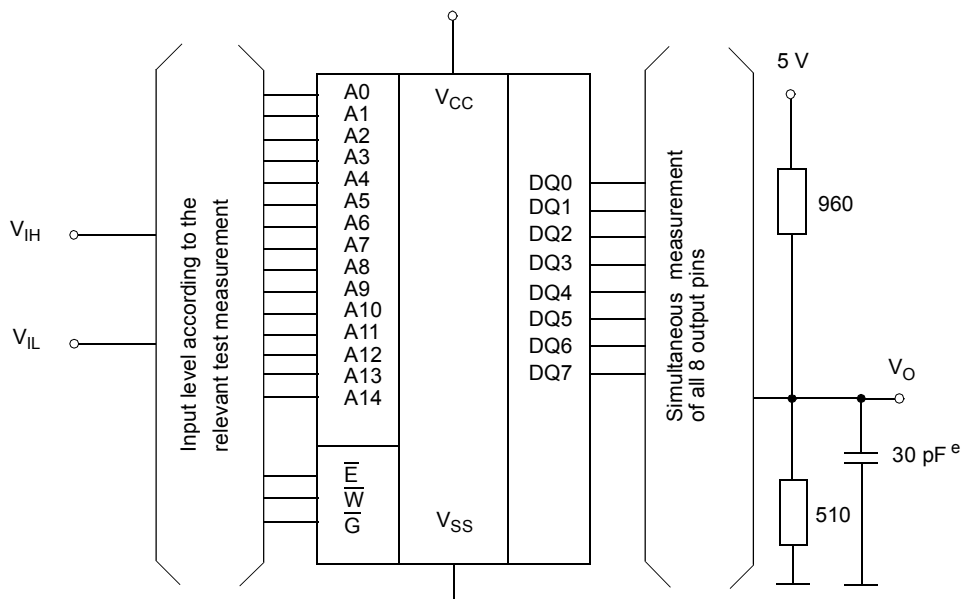
\bar{E} -Controlled



$$V_{CC(DR)} - 0.2 \text{ V} \leq V_{\bar{E}(DR)} \leq V_{CC(DR)} + 0.3 \text{ V}$$

Data Retention Characteristics	Symbol Alt. IEC	Conditions	Min.	Typ.	Max.	Unit
Data Retention Supply Voltage	$V_{CC(DR)}$		2		5.5	V
Data Retention Supply Current	$I_{CC(DR)}$	$V_{CC(DR)} = 3 \text{ V}$ $V_{\bar{E}} = V_{CC(DR)} - 0.2 \text{ V}$ C-Type K-Type A-Type			3 6 30	μA μA μA
Data Retention Setup Time	t_{CDR}	$t_{su(DR)}$	0			ns
Operating Recovery Time	t_R	t_{rec}	t_{cR}			ns

Test Configuration for Functional Check



^e In measurement of $t_{dis(E)}$, $t_{dis(W)}$, $t_{dis(G)}$, $t_{en(E)}$, $t_{en(W)}$, $t_{en(G)}$ the capacitance is 5 pF.

Capacitance	Conditions	Symbol	Min.	Max.	Unit
Input Capacitance	$V_{CC} = 5.0\text{ V}$ $V_I = V_{SS}$	C_I	-	7	pF
Output Capacitance	$f = 1\text{ MHz}$ $T_a = 25\text{ °C}$	C_O	-	7	pF

All pins not under test must be connected with ground by capacitors.

Ordering Code

Example

U62256A S2 K 07 LL

Type

Package

D = PDIP28 (600 mil, only C/K-Type and 70 ns)
S2 = SOP28 (330 mil) Type 2

Operating Temperature Range

C = 0 to 70 °C
K = -40 to 85 °C
A = -40 to 125 °C

Access Time

07 = 70 ns
10 = 100 ns (only C/K-Type)

Leadfree Option

blank = Standard Package

G1 = Leadfree Green Package ^f

Power Consumption

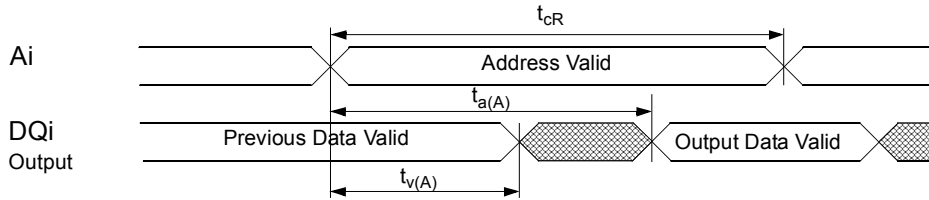
blank = Standard (only A-Type)

LL = Very Low Power (C/K-Type)

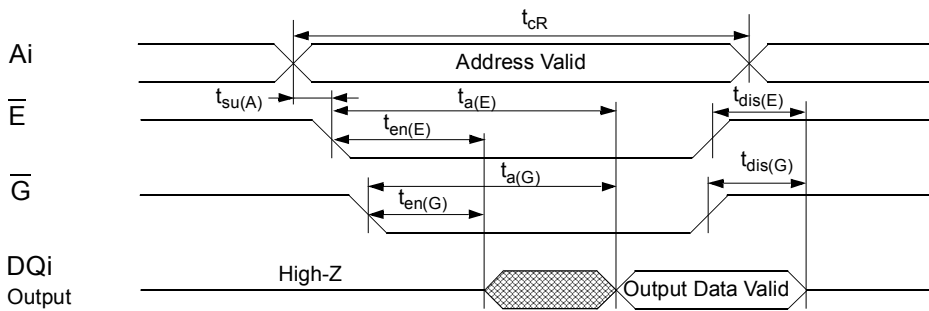
^f on special request

U62256A

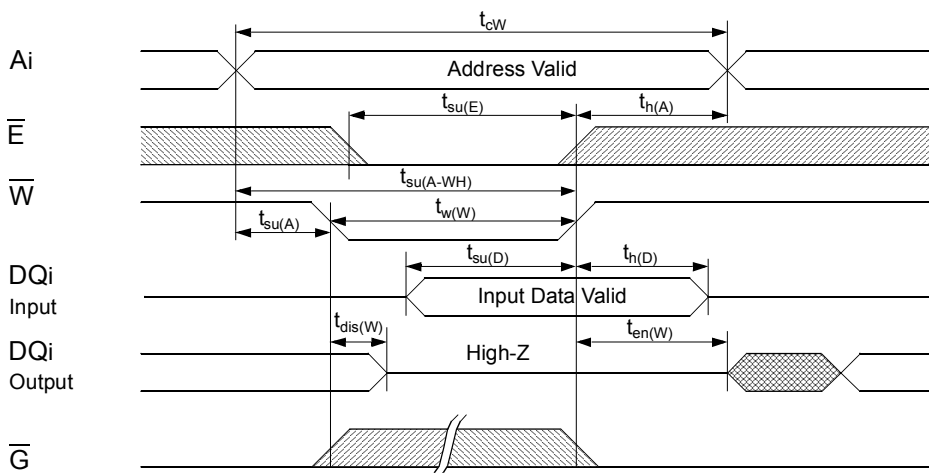
Read Cycle 1: Ai-controlled (during Read Cycle : $\bar{E} = \bar{G} = V_{IL}, \bar{W} = V_{IH}$)



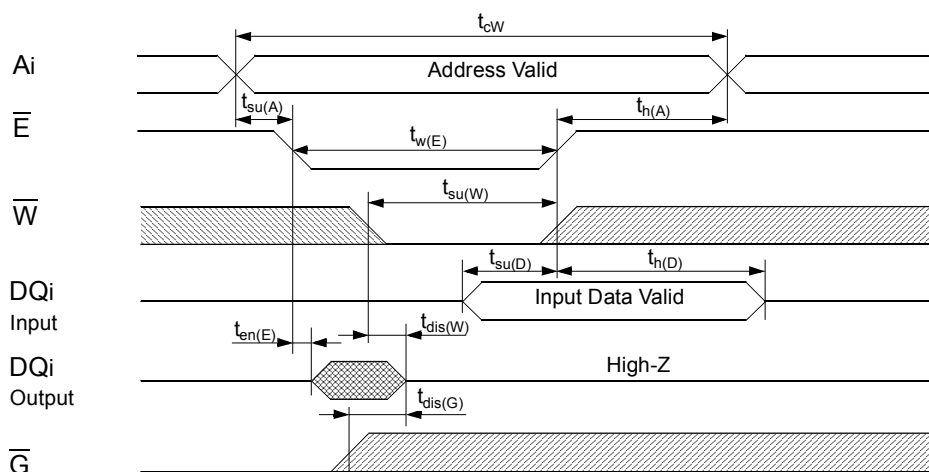
Read Cycle 2: \bar{G} -, \bar{E} -controlled (during Read Cycle: $\bar{W} = V_{IH}$)



Write Cycle1: \overline{W} -controlled



Write Cycle 2: \overline{E} -controlled



undefined  L- to H-level  H- to L-level 

The information describes the type of component and shall not be considered as assured characteristics. Terms of delivery and rights to change design reserved.

LIFE SUPPORT POLICY

ZMD products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the ZMD product could create a situation where personal injury or death may occur.

Components used in life-support devices or systems must be expressly authorized by ZMD for such purpose.

LIMITED WARRANTY

The information in this document has been carefully checked and is believed to be reliable. However Zentrum Mikroelektronik Dresden AG (ZMD) makes no guarantee or warranty concerning the accuracy of said information and shall not be responsible for any loss or damage of whatever nature resulting from the use of, or reliance upon it. The information in this document describes the type of component and shall not be considered as assured characteristics.

ZMD does not guarantee that the use of any information contained herein will not infringe upon the patent, trademark, copyright, mask work right or other rights of third parties, and no patent or licence is implied hereby. This document does not in any way extend ZMD's warranty on any product beyond that set forth in its standard terms and conditions of sale.

ZMD reserves terms of delivery and reserves the right to make changes in the products or specifications, or both, presented in this publication at any time and without notice.

Данный компонент на территории Российской Федерации

Вы можете приобрести в компании MosChip.

Для оперативного оформления запроса Вам необходимо перейти по данной ссылке:

<http://moschip.ru/get-element>

Вы можете разместить у нас заказ для любого Вашего проекта, будь то серийное производство или разработка единичного прибора.

В нашем ассортименте представлены ведущие мировые производители активных и пассивных электронных компонентов.

Нашей специализацией является поставка электронной компонентной базы двойного назначения, продукции таких производителей как XILINX, Intel (ex.ALTERA), Vicor, Microchip, Texas Instruments, Analog Devices, Mini-Circuits, Amphenol, Glenair.

Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

Офис по работе с юридическими лицами:

105318, г.Москва, ул.Щербаковская д.3, офис 1107, 1118, ДЦ «Щербаковский»

Телефон: +7 495 668-12-70 (многоканальный)

Факс: +7 495 668-12-70 (доб.304)

E-mail: info@moschip.ru

Skype отдела продаж:

moschip.ru

moschip.ru_4

moschip.ru_6

moschip.ru_9